## Notice of References Cited

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Application/Control No. 10/026,871	Apricant(s)/Patent Under Reexamination KAWAE ET AL.			
Examiner	Art Unit		_	
Kevin Quarterman	2879	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,472,765 B1	10-2002	Sano et al.	257/787
	В	US-5,962,971 A	10-1999	Chen, Hsing	313/512
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10200165 A	07-1998	Japan	SHIRAISHI et al.	H01L 33/00
	0	JP 2000022216 A	01-2000	Japan	SANO et al.	H01L 33/00
	Р					
	α					
	R					
	s					
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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